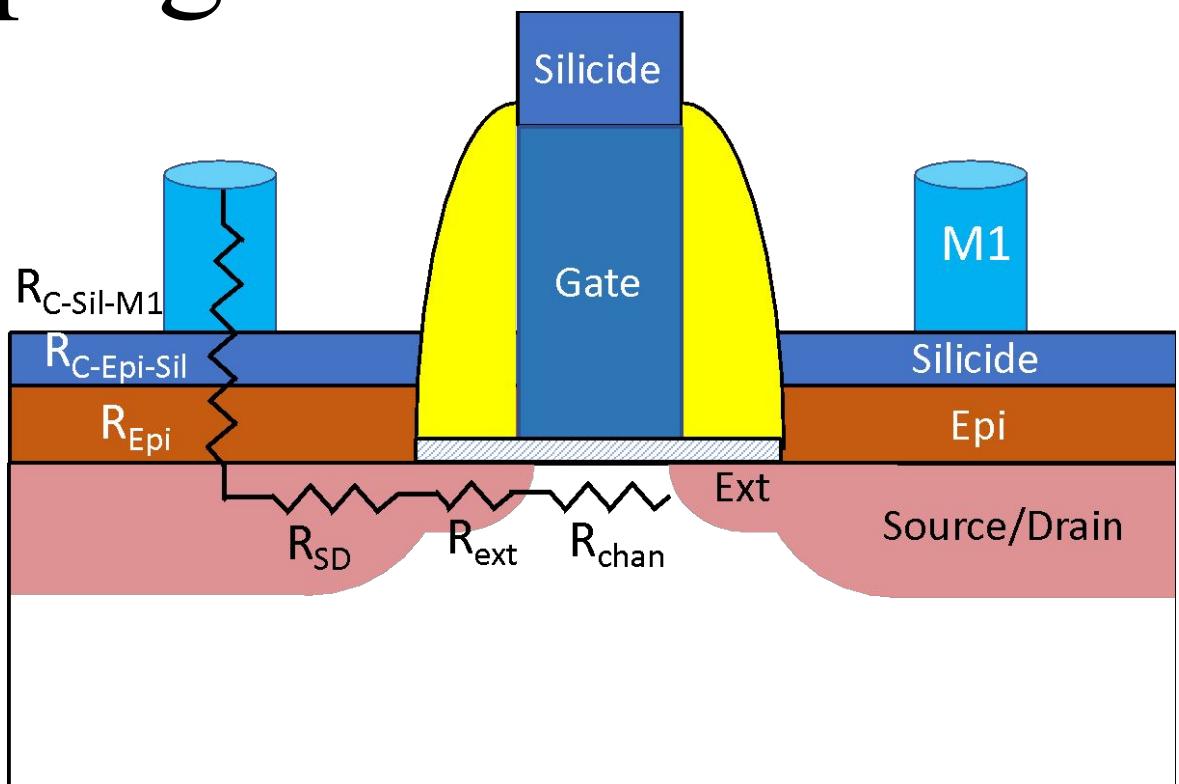
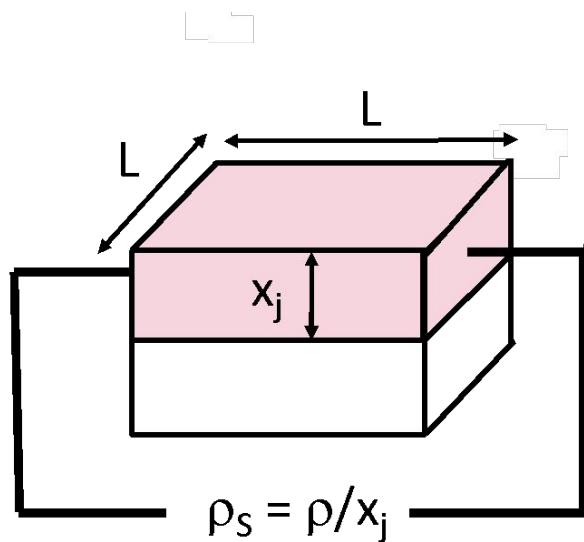
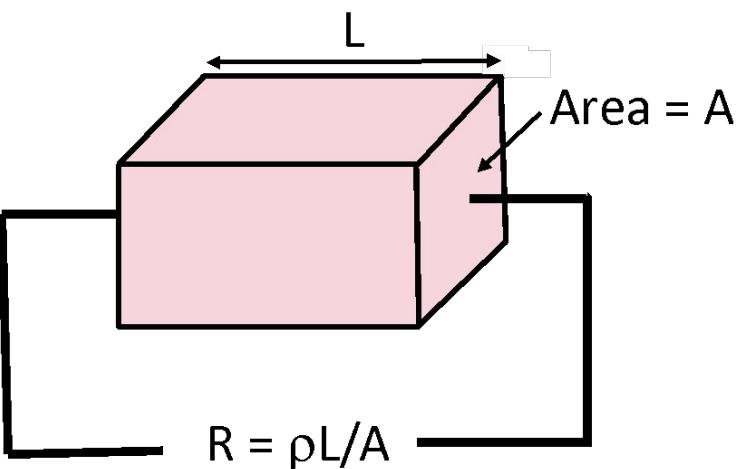


# Diffusion

# Doping



# Sheet resistance



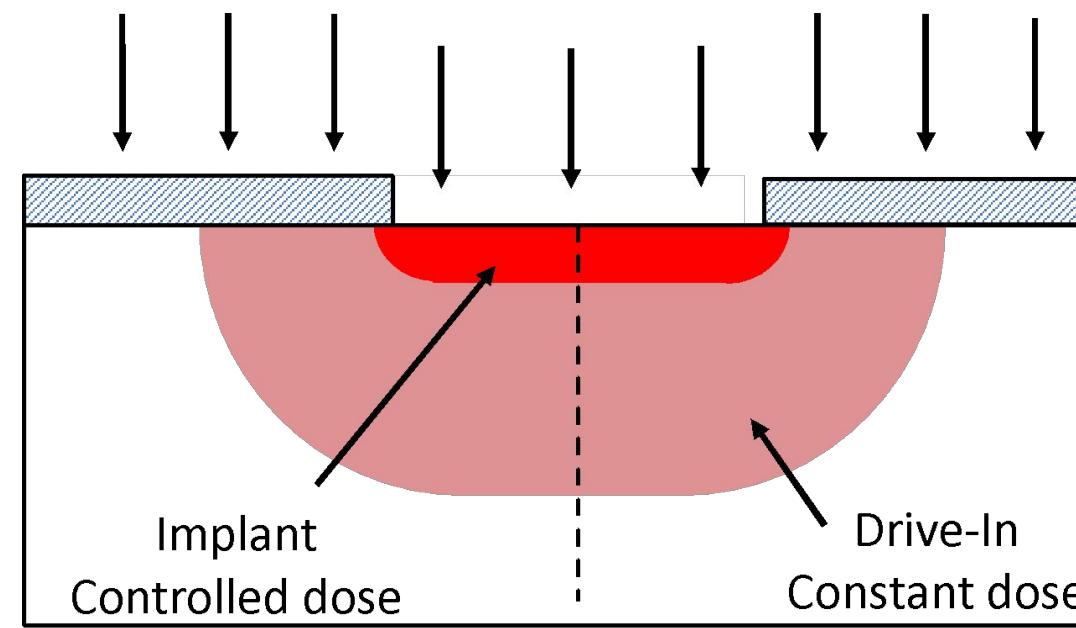
- All semiconductor devices depend on precision, local control of doping.
- Doping profiles are critical in all device characteristics.
- Resistance impacts drive current.
- Scaling implies all lateral and vertical dimensions scale by the same factor.
- Generally doping levels need to increase and  $x_j$  values need to decrease.

$$J = nqv = nq\mu\varepsilon = \sigma\varepsilon = \frac{1}{\rho} \varepsilon$$

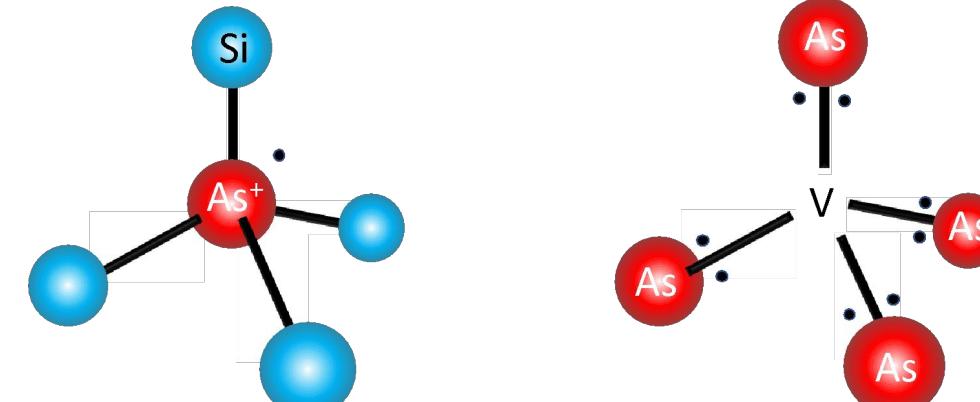
$$\rho = \frac{1}{nqv} = \frac{\varepsilon}{J} \Omega \cdot \text{cm}$$

$$\rho_s \equiv \frac{\rho}{x_j} \Omega/\text{square}$$

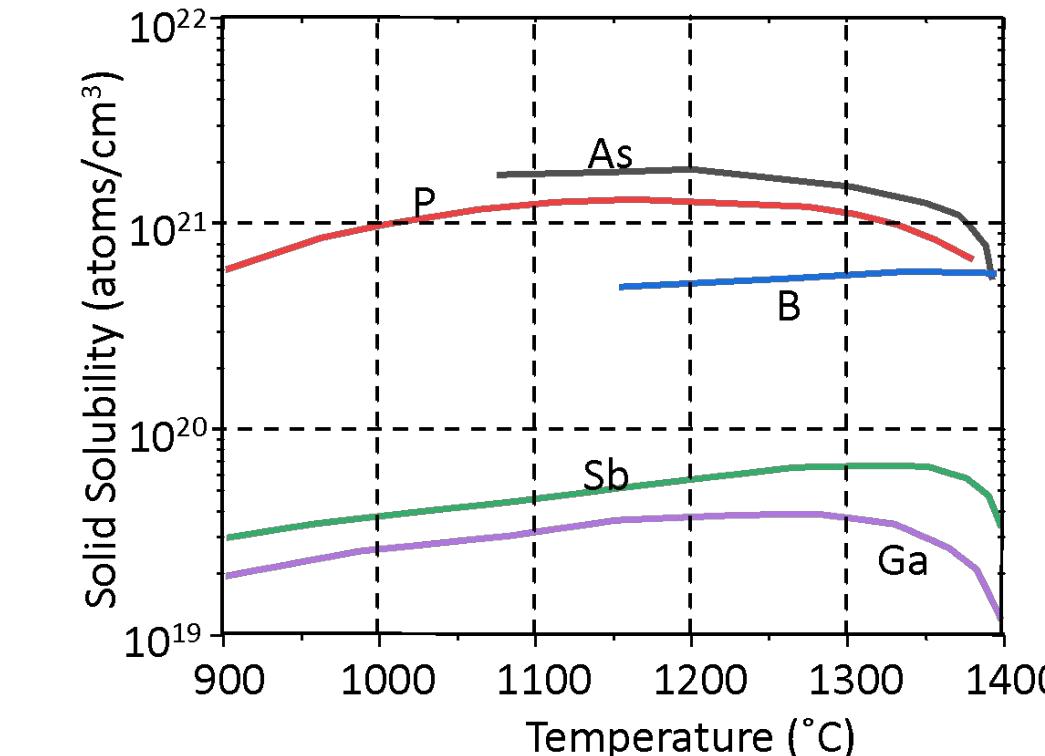
# Diffusion Steps



- Predeposition: usually an ion implantation step is used to introduce the required dose of dopant into the substrate.
- Drive-In: a subsequent drive-in anneal then redistributes the dopant giving the required  $x_J$  and surface concentration.

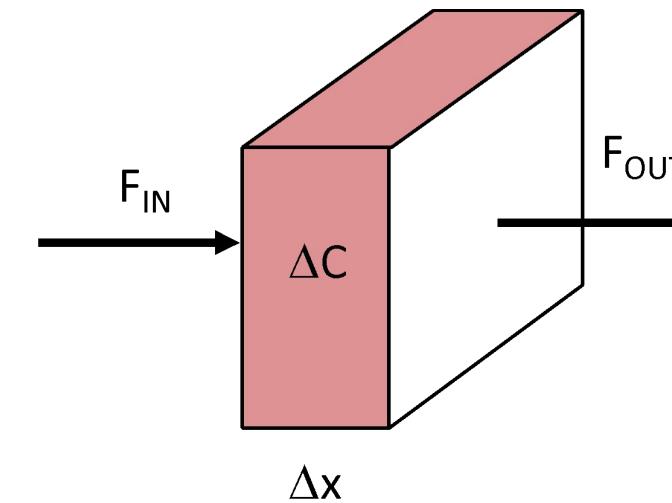
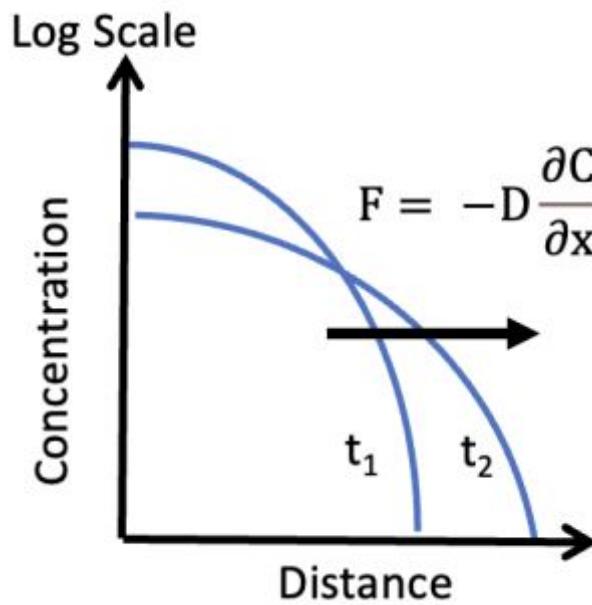


Electrically Active and Inactive Complexes



Solid Solubility Curves

# Macroscopic View – Gaussian Profile



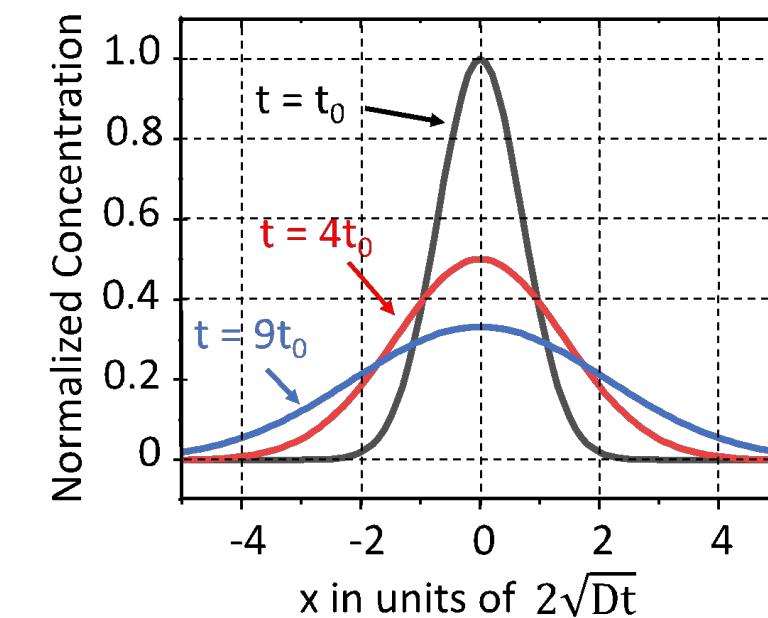
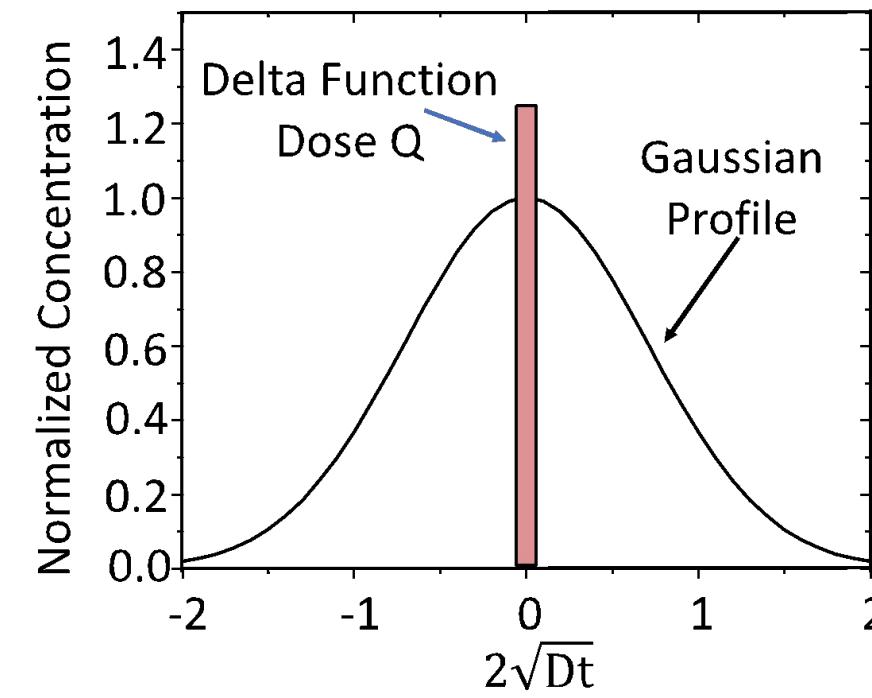
$$F = -D \frac{\partial C}{\partial x}$$

Fick's First Law

$$\frac{\partial C}{\partial t} = D \left( \frac{\partial^2 C}{\partial x^2} \right)$$

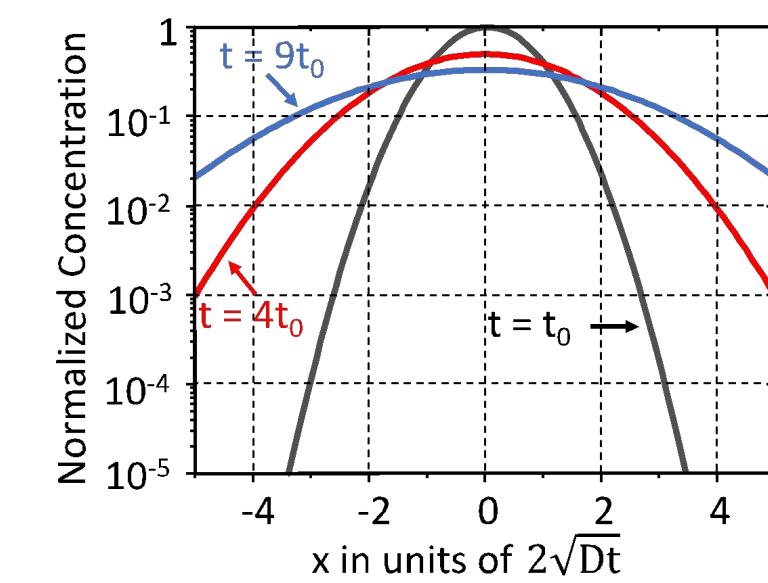
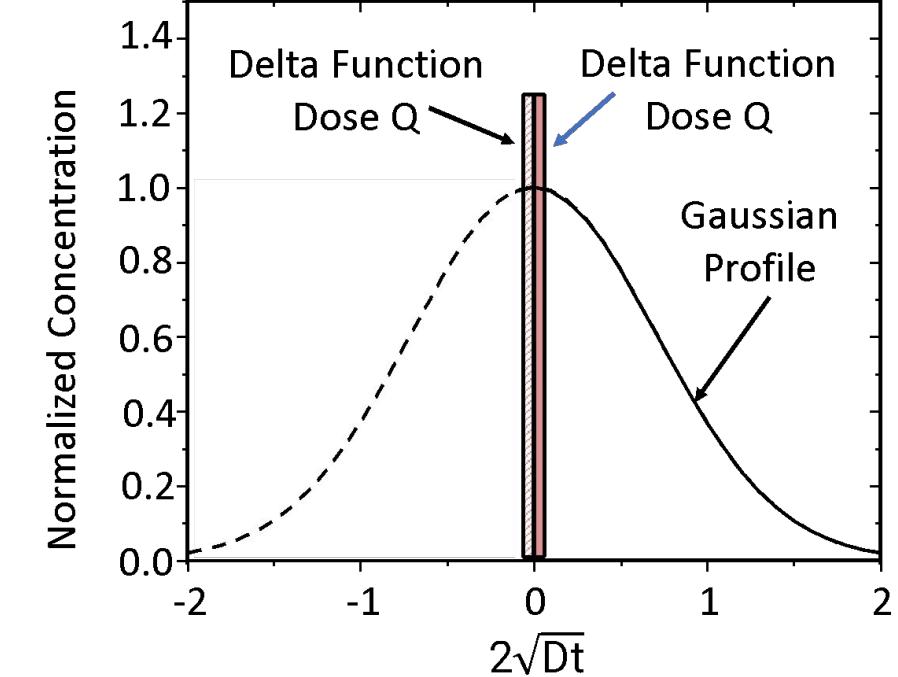
Fick's Second law

$$C(x, t) = \frac{Q}{2\sqrt{\pi Dt}} \exp\left(-\frac{x^2}{4Dt}\right) = C(0, t) \exp\left(-\frac{x^2}{4Dt}\right)$$

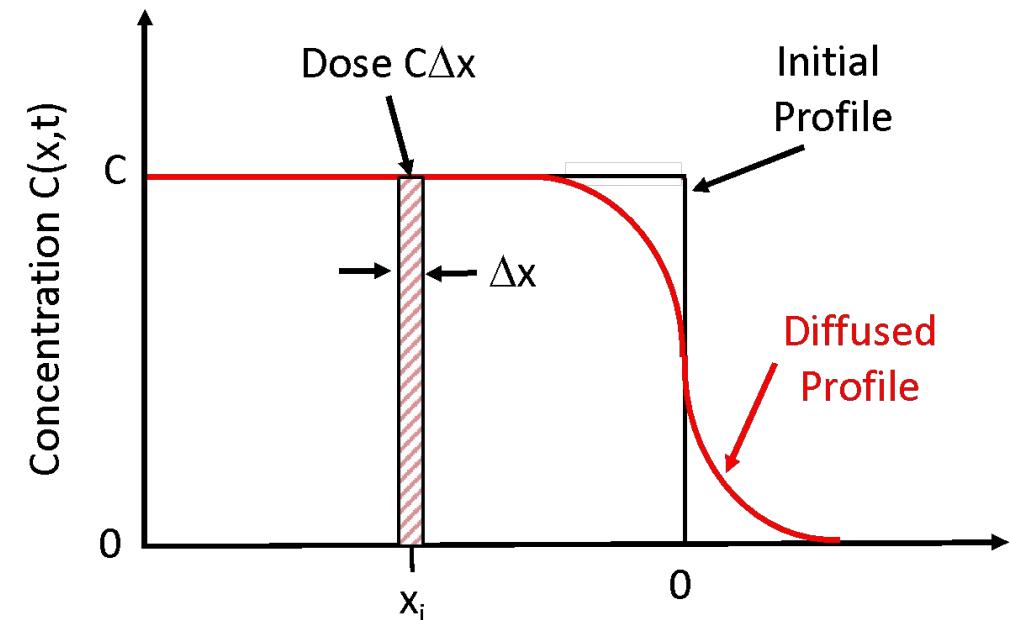


Important consequences:

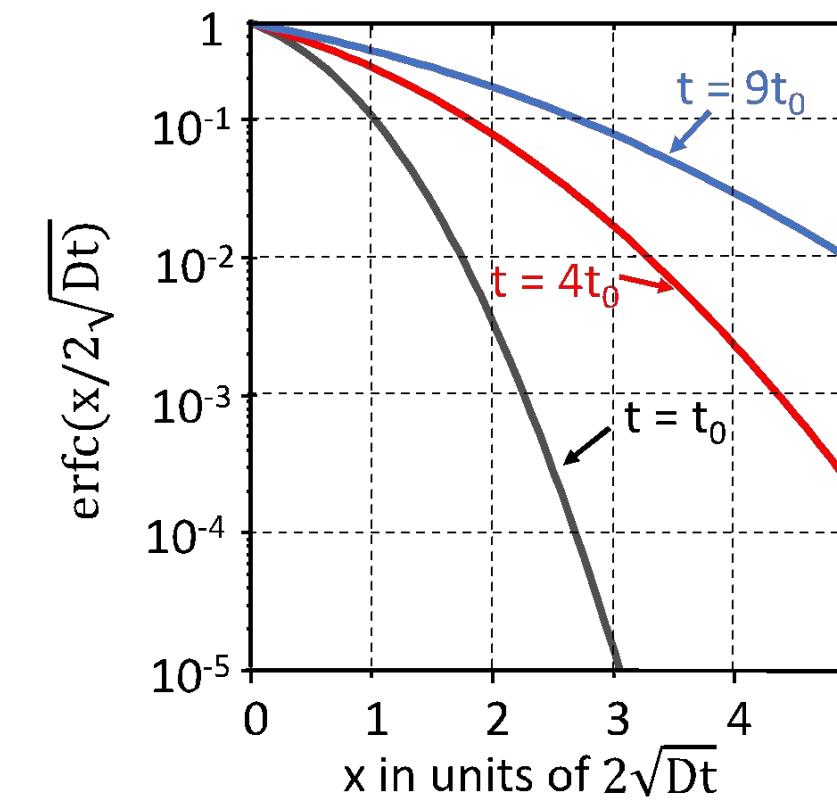
1. Dose Q remains constant
2. Peak concentration decreases as  $t^{-1/2}$
3. Diffusion distance increases as  $2(Dt)^{1/2}$



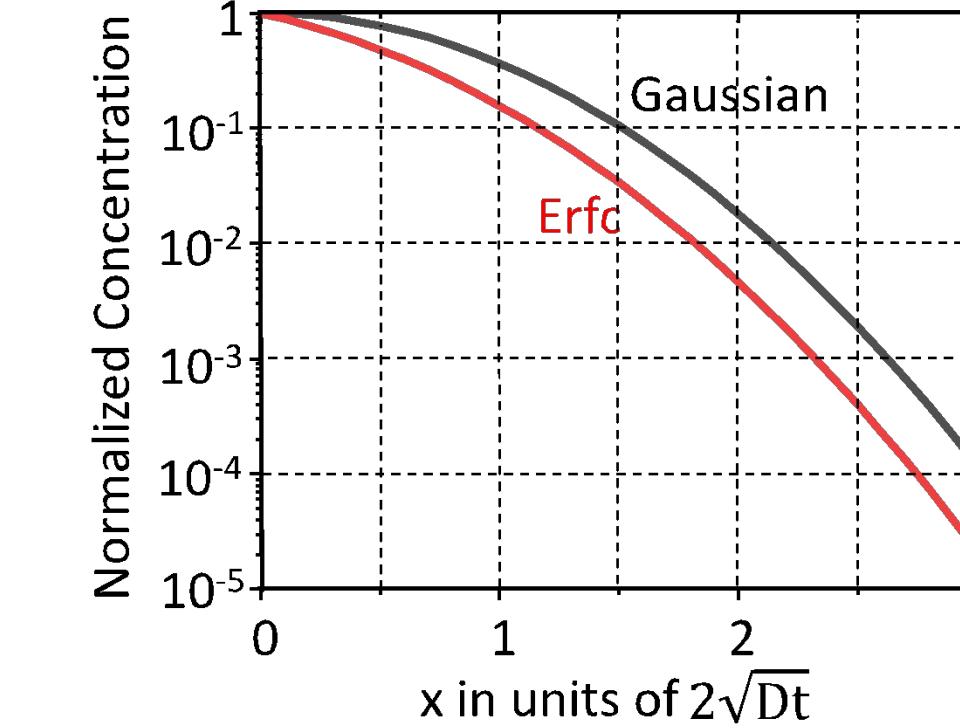
# Macroscopic View – erfc Profile



$$C(x, t) = \frac{C}{2} \left[ 1 - \text{erf}\left(\frac{x}{2\sqrt{Dt}}\right) \right] = \frac{C}{2} \left[ \text{erfc}\left(\frac{x}{2\sqrt{Dt}}\right) \right]$$

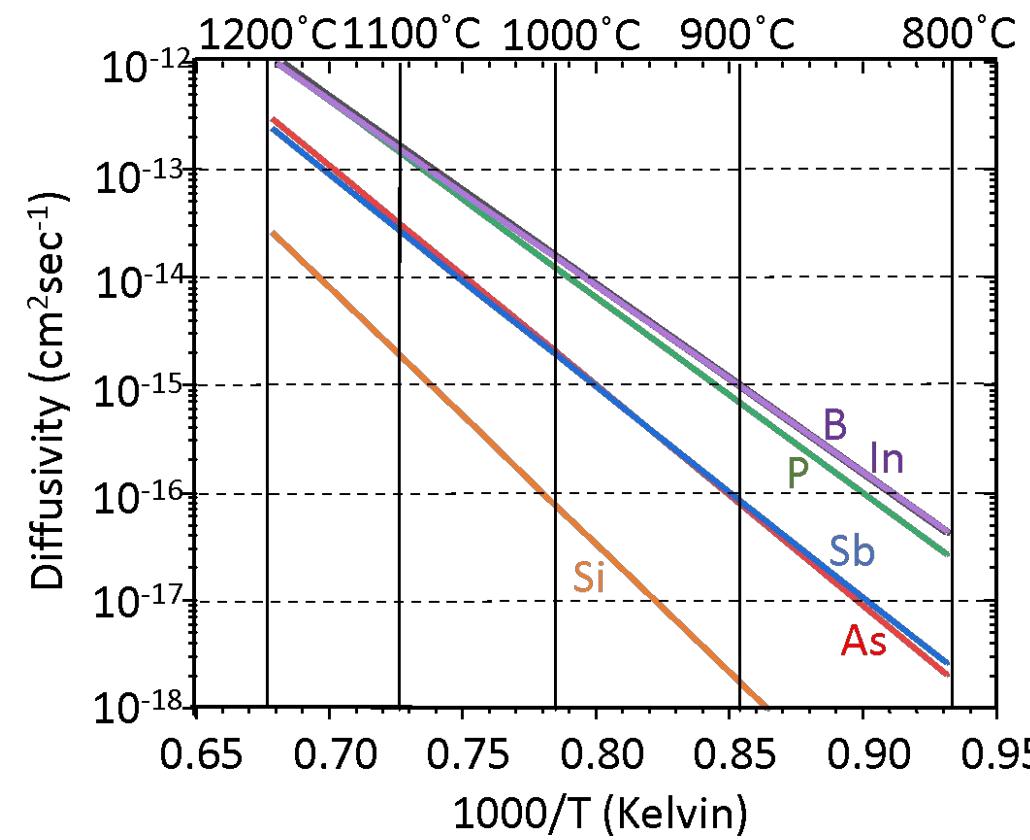


erfc profile



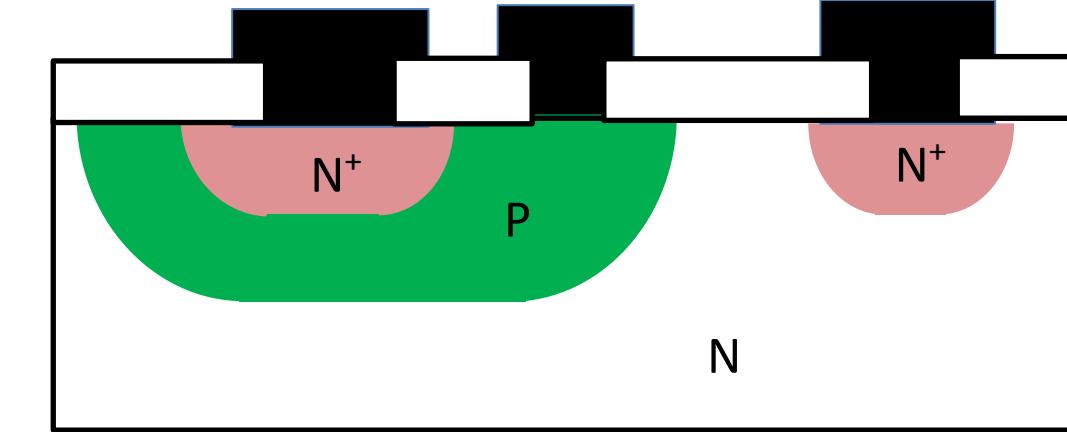
Comparison of Gaussian and erfc profile

# Diffusion Coefficient

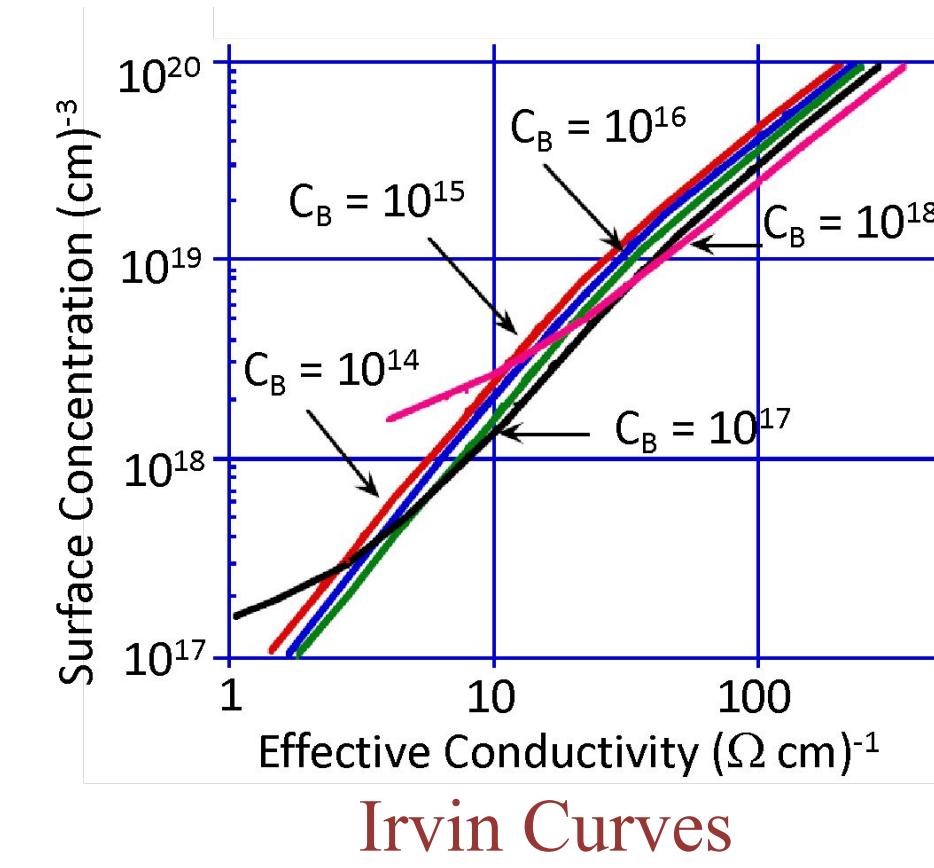


$$D = D^0 \exp\left(-\frac{E_A}{kT}\right)$$

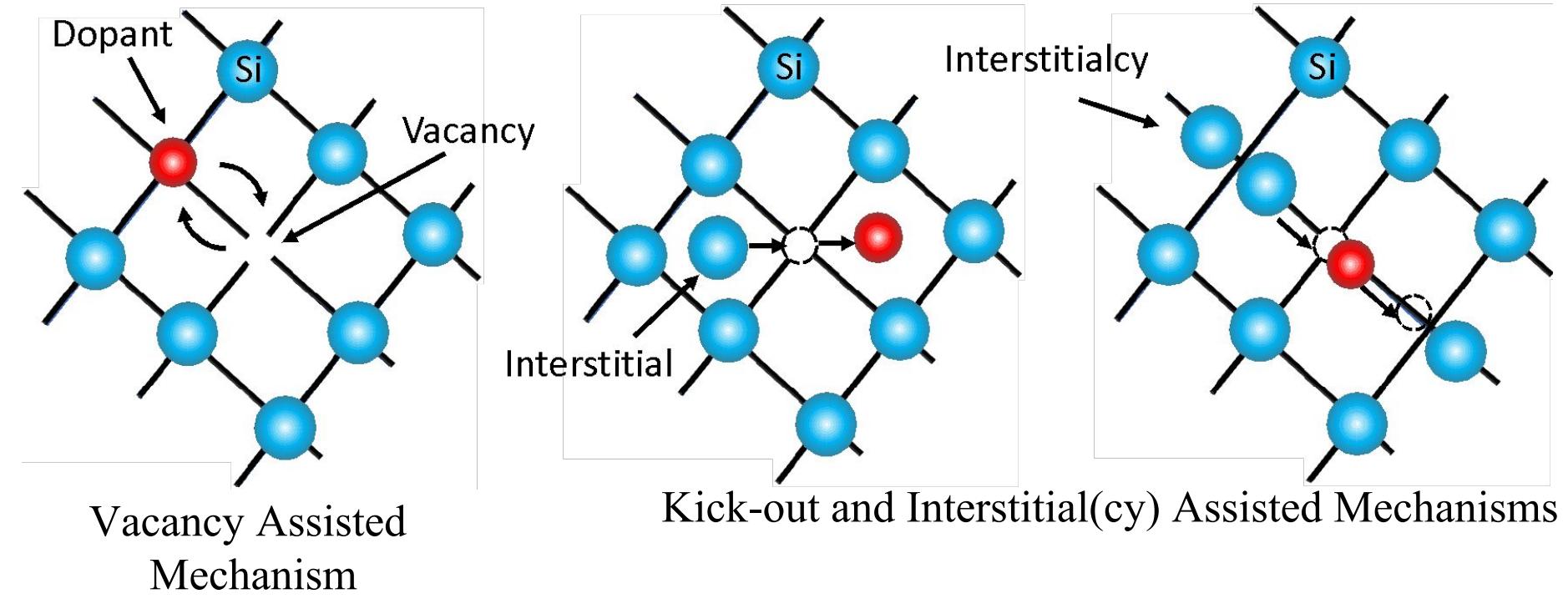
# Multiple Step diffusion



$$(Dt)_{\text{eff}} = D_1 t_1 + D_2 t_2 + \dots$$



# Diffusion at atomic scale



- Vacancy
- Interstitial
- Interstitialcy
- Kick Out

THANK YOU

